



Docket No.: 206584US90

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313



RE: Application Serial No.: 09/841,044

Applicants: Tsuneyuki HAGIWARA, et al.

Filing Date: April 25, 2001

For: AERIAL IMAGE MEASUREMENT METHOD AND
UNIT, OPTICAL PROPERTIES MEASUREMENT
METHOD AND UNIT, ADJUSTMENT METHOD OF
PROJECTION OPTICAL SYSTEM, EXPOSURE
METHOD AND APPARATUS, MAKING METHOD
OF EXPOSURE APPARATUS, AND DEVICE
MANUFACTURING METHOD

Group Art Unit: 2877

Examiner: STOCK, JR., G.

SIR:

Attached hereto for filing are the following papers:

SUPPLEMENTAL AMENDMENT

Our check in the amount of \$0.00 is attached covering any required fees. In the event any variance exists between the amount enclosed and the Patent Office charges for filing the above-noted documents, including any fees required under 37 C.F.R. 1.136 for any necessary Extension of Time to make the filing of the attached documents timely, please charge or credit the difference to our Deposit Account No. 15-0030. Further, if these papers are not considered timely filed, then a petition is hereby made under 37 C.F.R. 1.136 for the necessary extension of time. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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DOCKET NO: 206584US90

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF :
TSUNEYUKI HAGIWARA, ET AL. : EXAMINER: STOCK JR., G.
SERIAL NO: 09/841,044 :
FILED: APRIL 25, 2001 : GROUP ART UNIT: 2877
FOR: AERIAL IMAGE MEASUREMENT :
METHOD AND UNIT, OPTICAL
PROPERTIES MEASUREMENT METHOD
AND UNIT, ADJUSTMENT METHOD OF
PROJECTION OPTICAL SYSTEM,
EXPOSURE METHOD AND
APPARATUS, MAKING METHOD OF
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SUPPLEMENTAL AMENDMENT

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated September 08, 2003, please amend the above-identified application as follows:

Amendments to the Specification begin on page 2 of this paper.

Remarks/Arguments begin on page 5 of this paper.